


<b>Search Notes</b>  	<b>Application/Control No.</b>  09706297	<b>Applicant(s)/Patent Under Reexamination</b>  TOCK
	<b>Examiner</b>  Nano, Sargon N	<b>Art Unit</b>  2457

SEARCHED			
Class	Subclass	Date	Examiner
709	201-207, 217-238, 244	7/19/10	AMN
715	234-237	7/19/10	AMN

SEARCH NOTES		
Search Notes	Date	Examiner
Consulted Primary Examiner Bharat Barot regarding appeal brief	7/18/06	AMN
Consulted Administrative Judge Joe Dixon regarding appeal brief	7/20/06	AMN
Consulted SPE Saleh Najjar, and Qas Kim Huynh and Brian Johnson regarding amendments filed and proper response	5/20/10	AMN
Consulted Qas Kim Huynh and Brian Johnson regarding response strategy		AMN
East Search (USPAT; USPGPUB; USOCR; USPAD; FPRS; JPO; EPO; DERWENT; IBM_TDB)	7/19/10	AMN
NPL Search (IEEE Xplore, ACM Digital Library, Google Scholar)	7/19/10	AMN
inventor Name Search for ODP	7/19/10	AMN
Consulted with SPE Asad Nawaz	8/23/2010	SN

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
709	217	7/19/10	AMN

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